

AOTL66912Q

100V N-Channel AlphaSGT™ **AEC-Q101 Qualified**

General Description

- AEC-Q101 Qualified
- Trench Power MOSFET AlphaSGTTM technology
- Low Rds(on)
- Higher in-rush current capability
- 175°C operating junction temperature
- MSL1 up to 260°C reflow
 RoHS 2.0 and Halogen-Free Compliant

Applications

- BLDC Motor Drive
- Battery Management

Product Summary

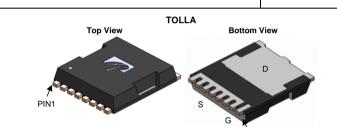
100V 370A I_D (at V_{GS}=10V) $R_{DS(ON)}$ (at V_{GS} =10V) < 1.7mΩ R_{DS(ON)} (at V_{GS}=6V) < 2.5mΩ

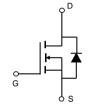
100% UIS Tested 100% Rg Tested

Max Tj=175°C









Orderable Part Number	Number Package Type		Minimum Order Quantity
AOTL66912Q	TOLLA	Tape & Reel	2000

Parameter	Symbol	Maximum	Units V	
Drain-Source Voltage	V_{DS}	100		
Gate-Source Voltage	V _{GS}	±20	V	
Continuous Drain T _C =25°C	ı	370		
Current T _C =100°C	I _D	260	A	
Pulsed Drain Current C (≤100µS)	I _{DM}	1480		
Continuous Drain T _A =25°C		53		
Current T _A =70°C	IDSM	44	Α Α	
Avalanche Current C	I _{AS}	90	А	
Avalanche energy L=0.1mH ^C	E _{AS}	405	mJ	
T _C =25°C	P _D	500	W	
Power Dissipation B T _C =100°C	P _D	250	VV	
T _A =25°C	ь	10	W	
Power Dissipation ^A T _A =70°C	P _{DSM}	7	vv	
Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 175	°C	

Thermal Characteristics					
Parameter		Symbol Typ Max		Units	
Maximum Junction-to-Ambient A	t ≤ 10s	D	10	15	°C/W
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	35	45	°C/W
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.2	0.3	°C/W



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units		
STATIC PARAMETERS								
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu A,\ V_{GS}=0V$	100			V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V			1	μA		
	Cata Dadula di ana assessa	T _J =55°C			5	A		
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.5	3	3.5	V		
		V _{GS} =10V, I _D =100A		1.4	1.7	mΩ		
R _{DS(ON)}	Static Drain-Source On-Resistance	T _J =125°C		2.4	2.9			
		V_{GS} =6V, I_D =75A		2	2.5	mΩ		
g_{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=20A$		70		S		
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.67	1	V		
Is	Maximum Body-Diode Continuous Current				330	Α		
DYNAMIC	CPARAMETERS							
C _{iss}	Input Capacitance			12500		pF		
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =50V, f=1MHz		3190		pF		
C _{rss}	Reverse Transfer Capacitance			55		pF		
R_g	Gate resistance	f=1MHz	0.8	1.75	2.7	Ω		
SWITCH	NG PARAMETERS							
Q _g (10V)	Total Gate Charge			155	220	nC		
Q_{gs}	Gate Source Charge	V_{GS} =10V, V_{DS} =50V, I_{D} =20A		48		nC		
Q_{gd}	Gate Drain Charge			31		nC		
Q _{oss}	Output Charge	V_{GS} =0V, V_{DS} =50V		269		nC		
$t_{D(on)}$	Turn-On DelayTime			36		ns		
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =2.5 Ω ,		25		ns		
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		90		ns		
t _f	Turn-Off Fall Time			40		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs		55		ns		
Q_{rr}	Body Diode Reverse Recovery Charge	e I _F =20A, di/dt=500A/μs		335		nC		

A. The value of R_{0JA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{0JA} \(\square 10s and the maximum allowed junction temperature of 175° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

- C. Single pulse width limited by junction temperature $T_{J(MAX)}$ =175° C.
- D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.
- G. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C.

APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO MAKE CHANGES TO PRODUCT SPECIFICATIONS WITHOUT NOTICE. IT IS THE RESPONSIBILITY OF THE CUSTOMER TO EVALUATE SUITABILITY OF THE PRODUCT FOR THEIR INTENDED APPLICATION. CUSTOMER SHALL COMPLY WITH APPLICABLE LEGAL REQUIREMENTS, INCLUDING ALL APPLICABLE EXPORT CONTROL RULES, REGULATIONS AND LIMITATIONS.

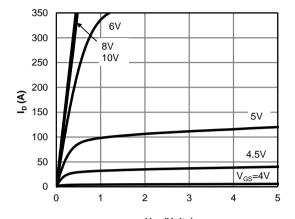
AOS' products are provided subject to AOS' terms and conditions of sale which are set forth at: http://www.aosmd.com/terms and conditions of sale

Rev.1.0: July 2023 **www.aosmd.com** Page 2 of 7

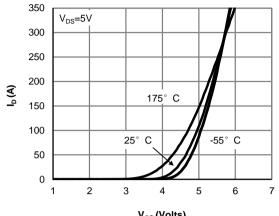
B. The power dissipation P_D is based on $T_{J(MAX)}=175^\circ$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



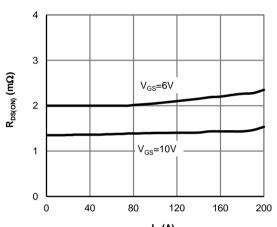
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



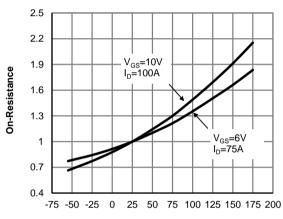
 ${
m V_{DS}}$ (Volts) Figure 1: On-Region Characteristics (Note E)



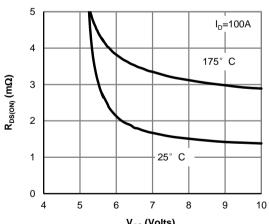
 V_{GS} (Volts) Figure 2: Transfer Characteristics (Note E)



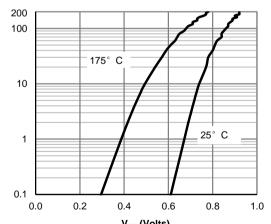
I_D (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction
Temperature (Note E)



V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

I_s (A)

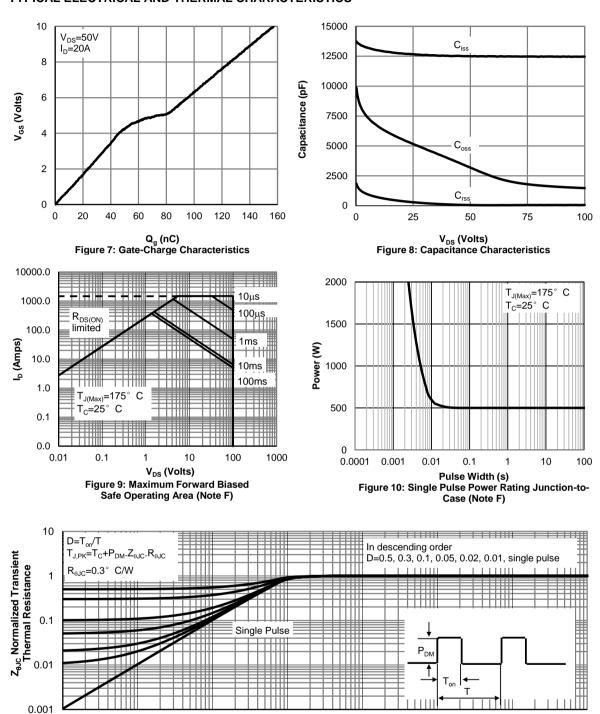


0.00001

0.0001

0.001

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.1

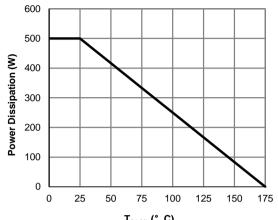
10

100

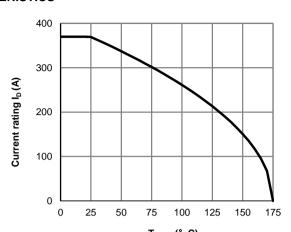
0.01



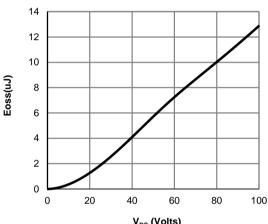
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



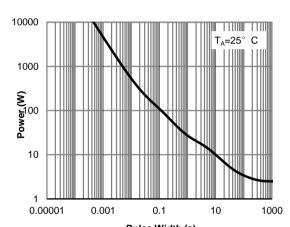
T_{CASE} (° C)
Figure 12: Power De-rating (Note F)



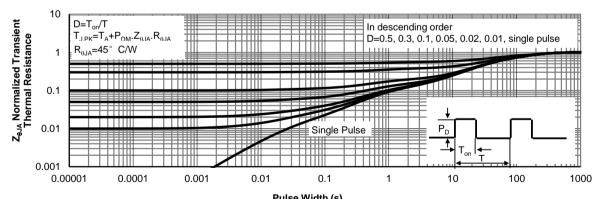
T_{CASE} (° C)
Figure 13: Current De-rating (Note F)



V_{DS} (Volts) Figure 14: Coss stored Energy



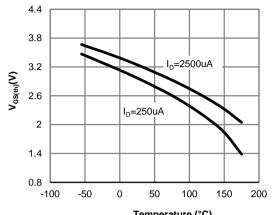
Pulse Width (s) Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note G)



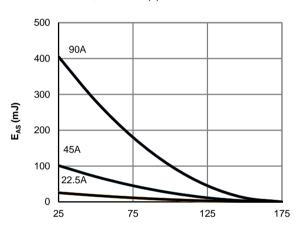
Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Temperature (°C)
Figure 17: V_{GS(th)} vs. Junction Temperature



Temperature (° C)
Figure 19: EAS vs. Junction Temperature

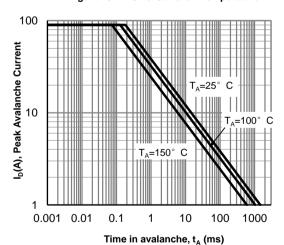


Figure 21: Single Pulse Avalanche capability

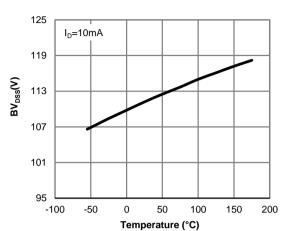
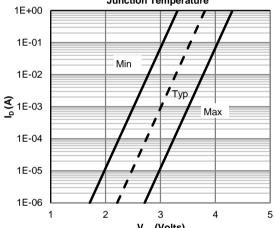


Figure 18: Drain-source breakdown voltage vs.
Junction Temperature



V_{GS} (Volts)
Figure 20: Transfer Characteristics (Note E)



Figure A: Gate Charge Test Circuit & Waveforms

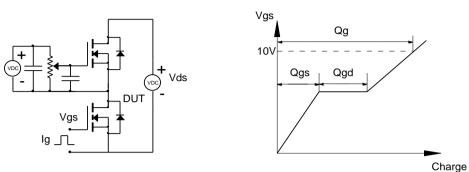


Figure B: Resistive Switching Test Circuit & Waveforms

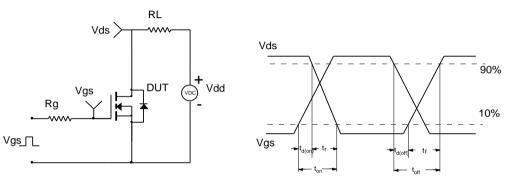


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

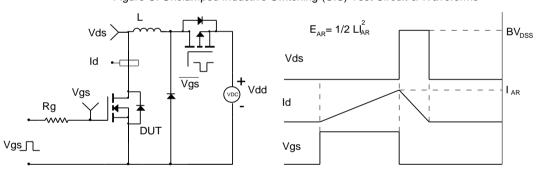
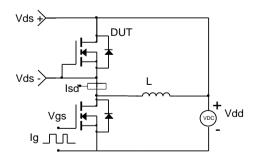
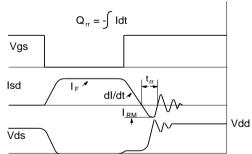


Figure D: Diode Recovery Test Circuit & Waveforms





Rev.1.0: July 2023 **www.aosmd.com** Page 7 of 7